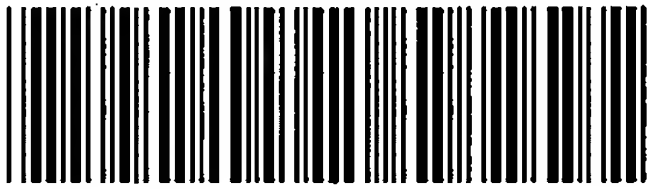


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/613,070	TAKESHITA, HITOSHI	
	Examiner	Art Unit	
	Luis F. Garcia	2613	

SEARCHED			
Class	Subclass	Date	Examiner
398	31		LG
398	32		LG
398	33		LG
398	76		LG
398	30		LG

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST WORD SEARCH		LG